# **EcoSPARK® 2 Ignition IGBT**

## 320 mJ, 450 V, N-Channel Ignition IGBT

#### **Features**

- SCIS Energy = 320 mJ at  $T_J = 25^{\circ}C$
- Logic Level Gate Drive
- Low Saturation Voltage
- AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free and are RoHS Compliant

### **Applications**

- Automotive Ignition Coil Driver Circuits
- High Current Ignition System
- Coil on Plug Application

### MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise stated)

Symbol	Parameter	Value	Unit
BV <sub>CER</sub>	Collector to Emitter Breakdown Voltage (IC = 1 mA)	450	V
BV <sub>ECS</sub>	Emitter to Collector Voltage – Reverse Battery Condition (IC = 10 mA)	28	V
E <sub>SCIS25</sub>	ISCIS = 14.6 A, L = 3.0 mHy, RGE = 1 K $\Omega$ , T $_{\rm C}$ = 25°C (Note 1)	320	mJ
E <sub>SCIS150</sub>	ISCIS = 10.9 A, L = 3.0 mHy, RGE = 1 K $\Omega$ , T $_{\rm C}$ = 150°C (Note 2)	180	mJ
IC25	Collector Current Continuous at VGE = 4.0 V, T <sub>C</sub> = 25°C	23	Α
IC110	Collector Current Continuous at VGE = 4.0 V, T <sub>C</sub> = 110°C	23	Α
$V_{GEM}$	Gate to Emitter Voltage Continuous	±10	٧
PD	Power Dissipation Total, T <sub>C</sub> = 25°C	150	W
	Power Dissipation Derating, T <sub>C</sub> > 25°C	1.1	W/°C
T <sub>J</sub> , T <sub>STG</sub>	Operating Junction and Storage Temperature	–55 to +175	°C
T <sub>L</sub>	Lead Temperature for Soldering Purposes (1/8" from case for 10 s)	300	°C
T <sub>PKG</sub>	Reflow Soldering according to JESD020C	260	°C
ESD	HBM–Electrostatic Discharge Voltage at 100 pF, 1500 $\Omega$	4	kV
	CDM–Electrostatic Discharge Voltage at 1 $\Omega$	2	kV

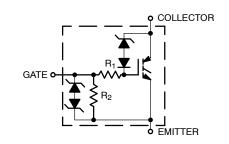
Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

- Self clamped inductive Switching Energy (ESCIS25) of 320 mJ is based on the test conditions that is starting T<sub>J</sub> = 25°C, L = 3 mHy, ISCIS = 14.6 A, VCC = 100 V during inductor charging and VCC = 0 V during time in clamp.
- Self Clamped inductive Switching Energy (ESCIS150) of 180 mJ is based on the test conditions that is starting T<sub>J</sub> = 150°C, L = 3mHy, ISCIS = 10.9 A, VCC = 100 V during inductor charging and VCC = 0 V during time in clamp.



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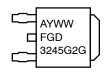
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DPAK (SINGLE GAUGE) CASE 369C

### MARKING DIAGRAM



A = Assembly Location

Y = Year

WW = Work Week

FGD3245G2= Device Code

G = Pb-Free Package

#### **ORDERING INFORMATION**

See detailed ordering and shipping information on page 2 of this data sheet.

### THERMAL RESISTANCE RATINGS

Characteristic	Symbol	Max	Units
Junction-to-Case - Steady State (Drain)	$R_{ heta JC}$	0.9	°C/W

### **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = 25°C unless otherwise specified)

Symbol	Parameter	Test Conditions		Min	Тур.	Max.	Units
OFF CHARA	ACTERISTICS						
BV <sub>CER</sub>	Collector to Emitter Breakdown Voltage	$I_{CE}$ = 2 mA, $V_{GE}$ = 0 V, $R_{GE}$ = 1 k $\Omega$ , $T_{J}$ = -40 to 150°C		420	_	480	V
BV <sub>CES</sub>	Collector to Emitter Breakdown Voltage	$I_{CE}$ = 10 mA, $V_{GE}$ = 0 V, $R_{GE}$ = 0, $T_{J}$ = -40 to 150°C		440	-	500	V
BV <sub>ECS</sub>	Emitter to Collector Breakdown Voltage	$I_{CE} = -75 \text{ mA}, V_{GE} = 0 \text{ V}, T_{J} = 25^{\circ}\text{C}$		28	-	-	V
BV <sub>GES</sub>	Gate to Emitter Breakdown Voltage	I <sub>GES</sub> = ±2 mA		±12	±14	-	V
I <sub>CER</sub>	Collector to Emitter Leakage Current	V <sub>CE</sub> = 175 V	T <sub>J</sub> = 25°C	-	-	25	μΑ
		$R_{GE} = 1 \text{ k}\Omega$	T <sub>J</sub> = 150°C	-	-	1	]
I <sub>ECS</sub>	Emitter to Collector Leakage Current	V <sub>EC</sub> = 24 V	T <sub>J</sub> = 25°C	-	-	1	mA
			T <sub>J</sub> = 150°C	-	-	40	1
R <sub>1</sub>	Series Gate Resistance			-	120	-	Ω
R <sub>2</sub>	Gate to Emitter Resistance			10K	-	30K	Ω
ON CHARA	CTERISTICS					•	
V <sub>CE(SAT)</sub>	Collector to Emitter Saturation Voltage	I <sub>CE</sub> = 6 A, V <sub>GE</sub> = 4 V, T <sub>J</sub> = 25°C		-	1.13	1.25	V
V <sub>CE(SAT)</sub>	Collector to Emitter Saturation Voltage	I <sub>CE</sub> = 10 A, V <sub>GE</sub> = 4.5 V, T <sub>J</sub> = 150°C		-	1.32	1.50	V
V <sub>CE(SAT)</sub>	Collector to Emitter Saturation Voltage	I <sub>CE</sub> = 15 A, V <sub>GE</sub> = 5 V, T <sub>J</sub> = 150°C		-	1.64	1.85	V
DYNAMIC C	HARACTERISTICS						
Q <sub>G(ON)</sub>	Gate Charge	I <sub>CE</sub> = 10 A, V <sub>CE</sub> = 12 V, V <sub>GE</sub> = 5 V		_	23	-	nC
V <sub>GE(TH)</sub>	Gate to Emitter Threshold Voltage	I <sub>CE</sub> = 1 mA V <sub>CE</sub> = V <sub>GE</sub>	T <sub>J</sub> = 25°C	1.3	1.6	2.2	V
			T <sub>J</sub> = 150°C	0.75	1.1	1.8	
$V_{GEP}$	Gate to Emitter Plateau Voltage	V <sub>CE</sub> = 12 V, I <sub>CE</sub> = 10 A		_	2.7	-	V
SWITCHING	CHARACTERISTICS						
td <sub>(ON)R</sub>	Current Turn-On Delay Time-Resistive	$V_{CE}$ = 14 V, $R_{L}$ = 1 $\Omega$ , $V_{GE}$ = 5 V, $R_{G}$ = 470 $\Omega$ , $T_{J}$ = 25°C		_	0.9	4	μs
t <sub>rR</sub>	Current Rise Time-Resistive			_	2.6	7	]
td <sub>(OFF)L</sub>	Current Turn-Off Delay Time-Inductive	$V_{CE}$ = 300 V, L = 1 mH, $V_{GE}$ = 5 V, R <sub>G</sub> = 470 $\Omega$ , $I_{CE}$ = 6.5 A, T <sub>J</sub> = 25°C		-	5.4	15	1
t <sub>fL</sub>	Current Fall Time-Inductive			_	2.7	15	1
							<u> </u>

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

### PACKAGE MARKING AND ORDERING INFORMATION

Device Marking	Device	Package	Reel Diameter	Tape Width	Qty <sup>†</sup>
FGD3245G2	FGD3245G2-F085V	DPAK (Pb-Free)	330 mm	16 mm	2500

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

#### TYPICAL CHARACTERISTICS

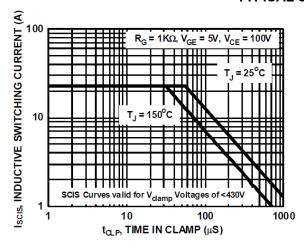


Figure 1. Self Clamped Inductive Switching Current vs. Time in Clamp

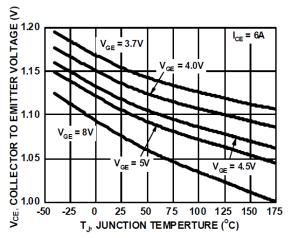


Figure 3. Collector to Emitter On-State Voltage vs. Junction Temperature

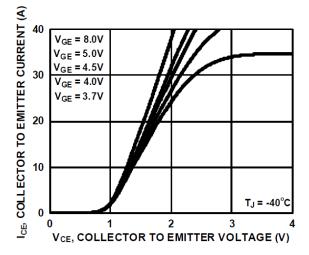


Figure 5. Collector to Emitter On-State Voltage vs. Collector Current

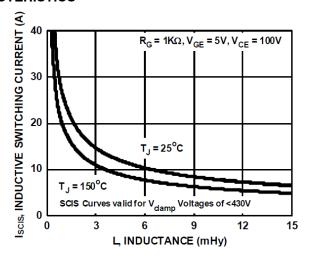


Figure 2. Self Clamped Inductive Switching Current vs. Inductance

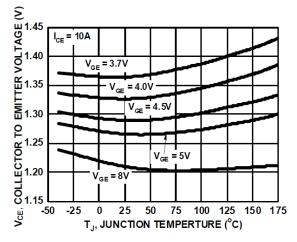


Figure 4. Collector to Emitter On-State Voltage vs. Junction Temperature

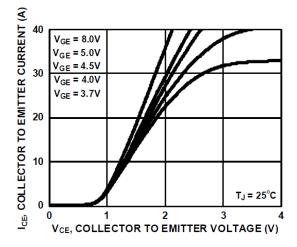


Figure 6. Collector to Emitter On-State Voltage vs. Collector Current

### TYPICAL CHARACTERISTICS (continued)

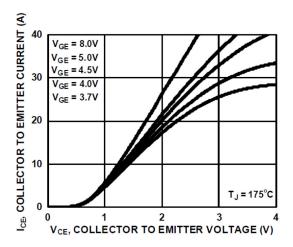


Figure 7. Collector to Emitter On-State Voltage vs. Collector Current

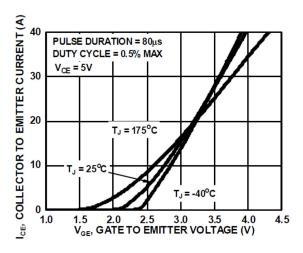


Figure 8. Transfer Characteristics

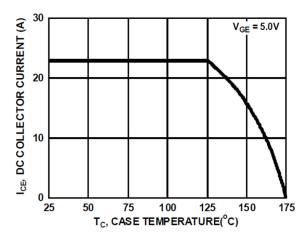


Figure 9. DC Collector Current vs. Case Temperature

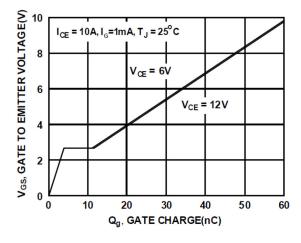


Figure 10. Gate Charge

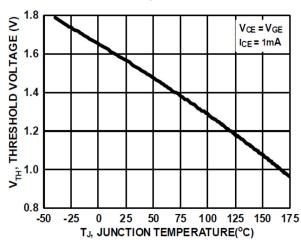


Figure 11. Threshold Voltage vs. Junction Temperature

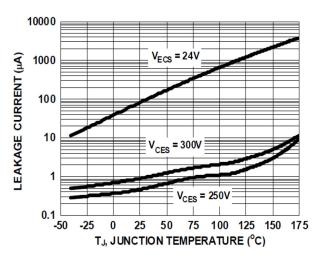
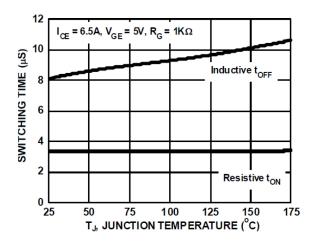


Figure 12. Leakage Current vs. Junction Temperature

### TYPICAL CHARACTERISTICS (continued)



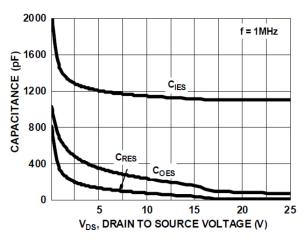


Figure 13. Switching Time vs. Junction Temperature

Figure 14. Capacitance vs. Collector to Emitter

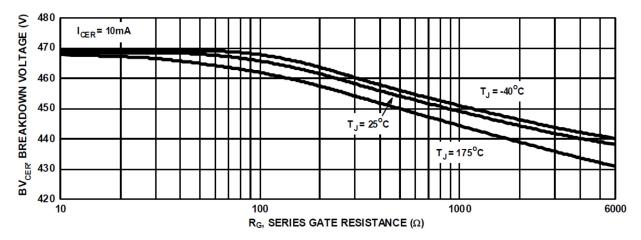


Figure 15. Break Down Voltage vs. Series Resistance

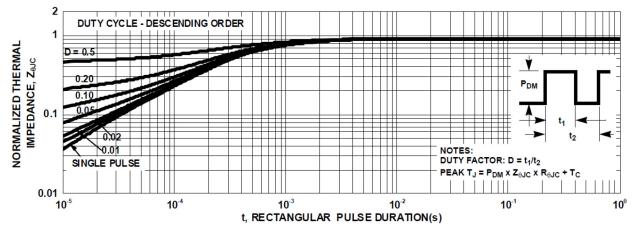
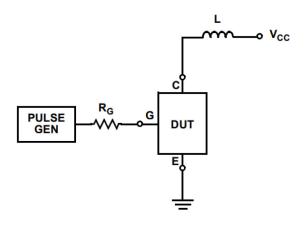


Figure 16. IGBT Normalized Transient Thermal Impedance, Junction to Case

### **TEST CIRCUIT AND WAVEFORMS**



 $R_G = 1K\Omega$  G DUT T  $V_{CC}$ 

Figure 17. Inductive Switching Test Circuit

Figure 18.  $t_{\text{ON}}$  and  $t_{\text{OFF}}$  Switching Test Circuit

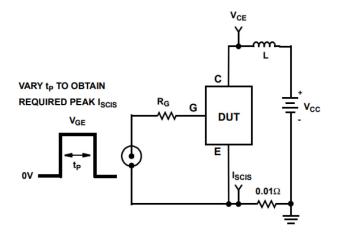


Figure 19. Energy Test Circuit

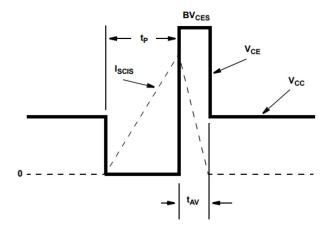


Figure 20. Energy Waveforms

В

NOTE 7

- h3

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**TOP VIEW** 

L3

b2 e

## **DPAK (SINGLE GAUGE)** CASE 369C **ISSUE F** SCALE 1:1 Α

DETAIL A

C-

SIDE VIEW

**DATE 21 JUL 2015** 

#### NOTES:

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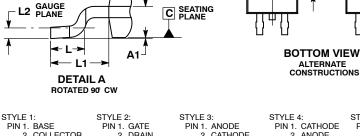
**BOTTOM VIEW** 

Z

- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994. 2. CONTROLLING DIMENSION: INCHES.
- 3. THERMAL PAD CONTOUR OPTIONAL WITHIN DI-
- MENSIONS b3, L3 and Z.
  4. DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR BURRS. MOLD FLASH, PROTRUSIONS, OR GATE BURRS SHALL NOT EXCEED 0.006 INCHES PER SIDE.
  5. DIMENSIONS D AND E ARE DETERMINED AT THE
- OUTERMOST EXTREMES OF THE PLASTIC BODY.

  6. DATUMS A AND B ARE DETERMINED AT DATUM
- 7. OPTIONAL MOLD FEATURE.

	INCHES		MILLIMETERS	
DIM	MIN	MAX	MIN	MAX
Α	0.086	0.094	2.18	2.38
A1	0.000	0.005	0.00	0.13
b	0.025	0.035	0.63	0.89
b2	0.028	0.045	0.72	1.14
b3	0.180	0.215	4.57	5.46
С	0.018	0.024	0.46	0.61
c2	0.018	0.024	0.46	0.61
D	0.235	0.245	5.97	6.22
E	0.250	0.265	6.35	6.73
е	0.090	BSC	2.29 BSC	
Н	0.370	0.410	9.40	10.41
L	0.055	0.070	1.40	1.78
L1	0.114 REF		2.90 REF	
L2	0.020 BSC		0.51 BSC	
L3	0.035	0.050	0.89	1.27
L4		0.040		1.01
Z	0.155		3.93	



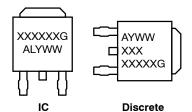
|  $\oplus$  | 0.005 (0.13) lacktriangledown C

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#### STYLE 5: PIN 1. BASE 2. COLLECTOR 3. EMITTER PIN 1. GATE 2. DRAIN PIN 1. ANODE 2. CATHODE 3. ANODE PIN 1. CATHODE PIN 1. GATE 2. ANODE 3. CATHODE 2. ANODE 3. GATE SOURCE 4. CATHODE ANODE 4. COLLECTOR 4. ANODE 4. DRAIN

STYLE 6:	STYLE 7:	STYLE 8:	STYLE 9:	STYLE 10:
PIN 1. MT1	PIN 1. GATE	PIN 1. N/C	PIN 1. ANODE	PIN 1. CATHODE
2. MT2	2. COLLECTOR	<ol><li>CATHODE</li></ol>	2. CATHODE	<ol><li>ANODE</li></ol>
3. GATE	<ol><li>EMITTER</li></ol>	<ol><li>ANODE</li></ol>	<ol><li>RESISTOR ADJUST</li></ol>	<ol><li>CATHODE</li></ol>
4. MT2	<ol><li>COLLECTOR</li></ol>	4. CATHODE	4. CATHODE	4. ANODE

### **GENERIC MARKING DIAGRAM\***

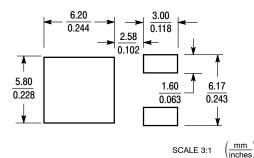


XXXXXX = Device Code = Assembly Location Α L = Wafer Lot Υ = Year

WW = Work Week G = Pb-Free Package

\*This information is generic. Please refer to device data sheet for actual part marking.

### **SOLDERING FOOTPRINT\***



\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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